

• General Description

It combines trench MOSFET technology with a low resistance package to provide extremely low  $R_{DS(ON)}$ .

• Features

- AEC-Q101 Qualified
- Low  $R_{DS(ON)}$  to minimize conductive loss
- High GOX reliability
- Low Thermal resistance

• Application

- BLDC Motor driver
- DC-DC
- Battery protection

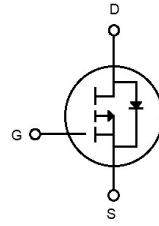
• Ordering Information:

Part NO.	ZMA029P03D
Marking	ZM029P03
Packing Information	REEL TAPE
Basic ordering unit (pcs)	2500

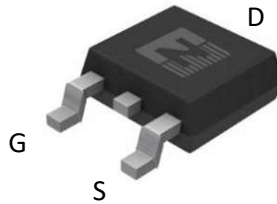
• Absolute Maximum Ratings ( $T_C=25^\circ\text{C}$ )

Parameter	Symbol	Conditions	Value	Unit
Drain-Source Voltage	$V_{DS}$		-30	V
Gate-Source Voltage <sup>①</sup>	$V_{GS}$		$\pm 20$	V
Continuous Drain Current	$I_D$	$T_C=25^\circ\text{C}$	-120	A
	$I_D$	$T_C=75^\circ\text{C}$	-99	A
	$I_D$	$T_C=100^\circ\text{C}$	-85	A
Pulsed Drain Current	$I_{DM}$	Pulsed; $t_p \leq 10 \mu\text{s}$ ; $T_{mb} = 25^\circ\text{C}$ ;	-480	A
Total Power Dissipation	$P_D$	$T_C=25^\circ\text{C}$	107	W
Total Power Dissipation	$P_D$	$T_A=25^\circ\text{C}$	2.4	W
Operating Junction Temperature	$T_J$		-55 to +175	$^\circ\text{C}$
Storage Temperature	$T_{STG}$		-55 to +175	$^\circ\text{C}$
Single Pulse Avalanche Energy	$E_{AS}$	$L=0.1\text{mH}$ , $V_{GS}=10\text{V}$ , $R_g=25\Omega$ ,	240	mJ
		$L=0.5\text{mH}$ , $V_{GS}=10\text{V}$ , $R_g=25\Omega$ ,	504	mJ
ESD Level (HBM)			CLASS 2	

• Product Summary



$V_{DS} = -30\text{V}$   
 $R_{DS(ON)} = 2.9\text{m}\Omega$   
 $I_D = -120\text{A}$



TO-252



**•Thermal resistance**

Parameter	Symbol	Min.	Typ.	Max.	Unit
Thermal resistance, junction - case	$R_{thJC}$		-	1.4	°C/W
Thermal resistance, junction-ambient <sup>②</sup>	$R_{thJA}$ <sup>②</sup>		-	62	°C/W
Soldering temperature	$T_{sold}$		-	260	°C

**•Electronic Characteristics**

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit
Drain-Source Breakdown Voltage	$BV_{DSS}$	$V_{GS} = 0V, I_D = -250\mu A$	-30			V
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{GS} = V_{DS}, I_D = -250\mu A$	-1.3	-1.8	-2.5	V
Drain-Source Leakage Current	$I_{DSS}$	$V_{GS} = 0V, V_{DS} = -30V$			1.0	$\mu A$
Gate- Source Leakage Current	$I_{GSS}$	$V_{GS} = \pm 20V, V_{DS} = 0V$			100	nA
Static Drain-source On Resistance	$R_{DS(ON)}$	$V_{GS} = -10V, I_D = -24A$		2.9	3.5	m $\Omega$
		$V_{GS} = -4.5V, I_D = -12A$		4.2	6	m $\Omega$
Forward Transconductance	$g_{FS}$	$V_{DS} = -5V, I_{SD} = -20A$		20		s
Diode Forward Voltage	$V_{FSD}$	$V_{GS} = 0V, I_{SD} = -24A$			1.3	V

**•Dynamic characteristics**

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit	
Input capacitance	$C_{iss}$	$f = 1MHz, V_{DS} = -25V$	-	10870	-	pF	
Output capacitance	$C_{oss}$		-	1082	-		
Reverse transfer capacitance	$C_{rss}$		-	854	-		
Gate Resistance	$R_g$	$f = 1MHz$	-	3		$\Omega$	
Total gate charge	$Q_g$	$V_{DD} = -15V, I_D = -20A, V_{GS} = -10V$	-	184	-	nC	
	$Q_g(-4.5v)$		-	83	-		
	Gate - Source charge		$Q_{gs}$	-	37		-
	Gate - Drain charge		$Q_{gd}$	-	23		-
Turn-ON Delay time	$t_{D(on)}$	$V_{GS} = -10V, V_{DS} = -15V, R_G = 3.3\Omega, I_D = -20A$	-	27	-	ns	
Turn-ON Rise time	$t_r$		-	105	-	ns	
Turn-Off Delay time	$t_{D(off)}$		-	98	-	ns	
Turn-Off Fall time	$t_f$		-	33	-	ns	

Fig.1 Gate-Charge Characteristics

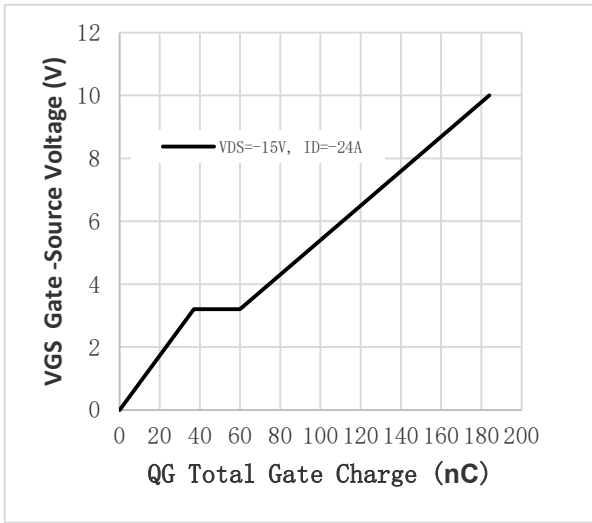


Fig.2 Capacitance Characteristics

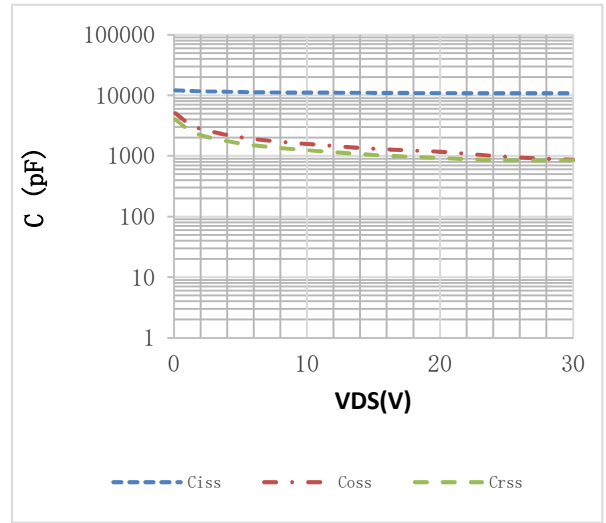


Fig.3 Power Dissipation

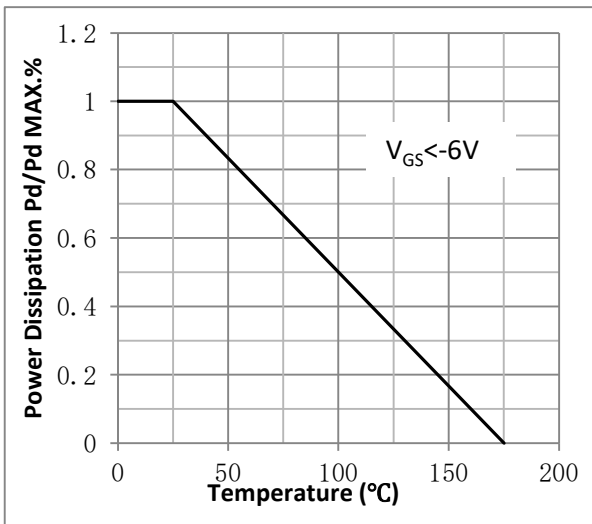


Fig.4 Typical output Characteristics

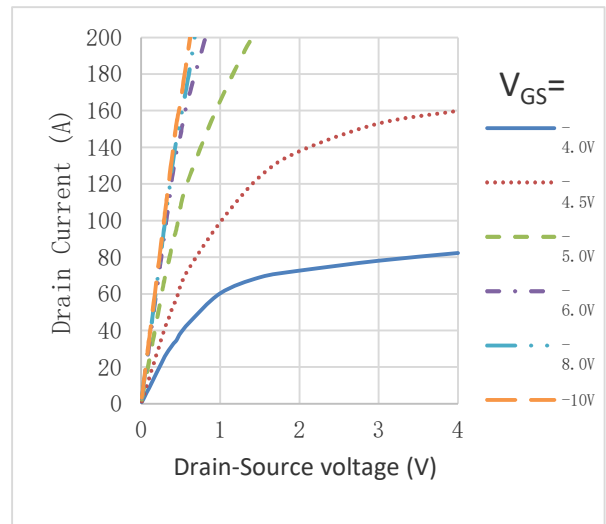


Fig.5 Threshold Voltage V.S Junction Temperature

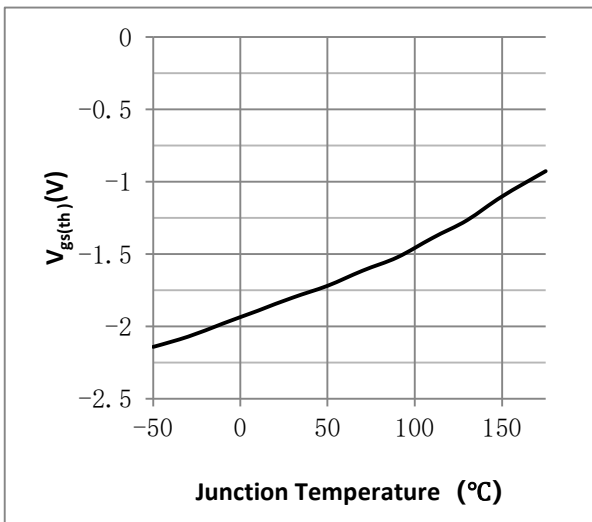


Fig.6 Resistance V.S Drain Current

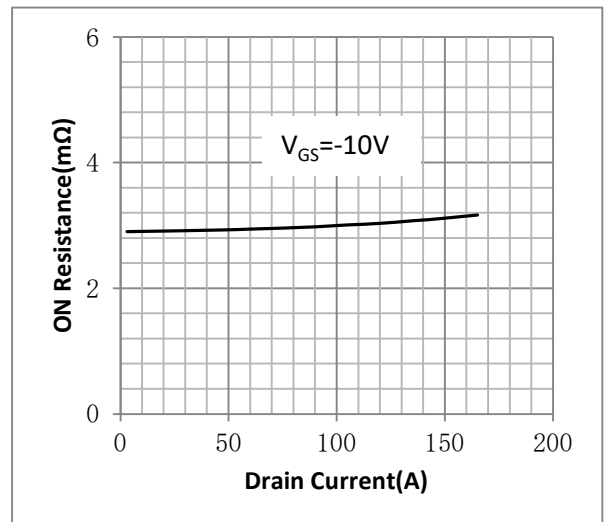


Fig.7 On-Resistance VS Gate Source Voltage

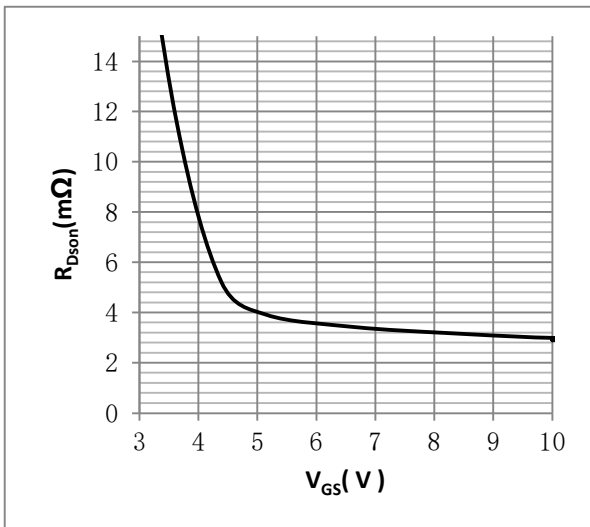


Fig.8 On-Resistance V.S Junction Temperature

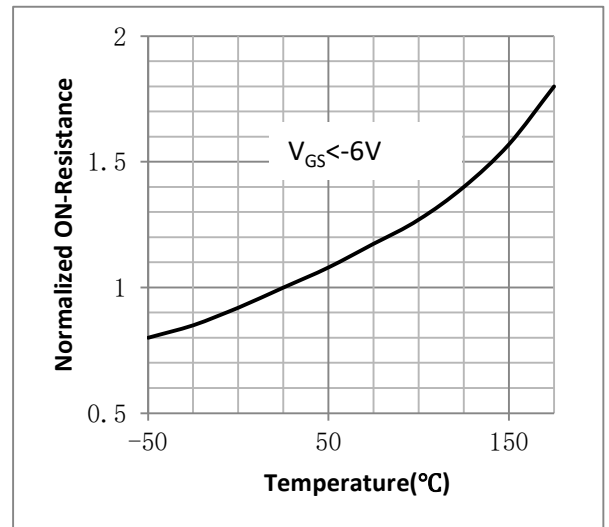


Figure 9. Diode Forward Voltage vs. Current

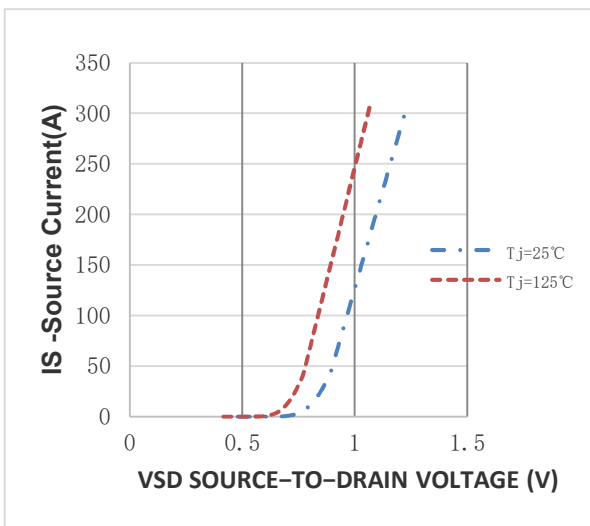


Figure 10. Transfer Characteristics

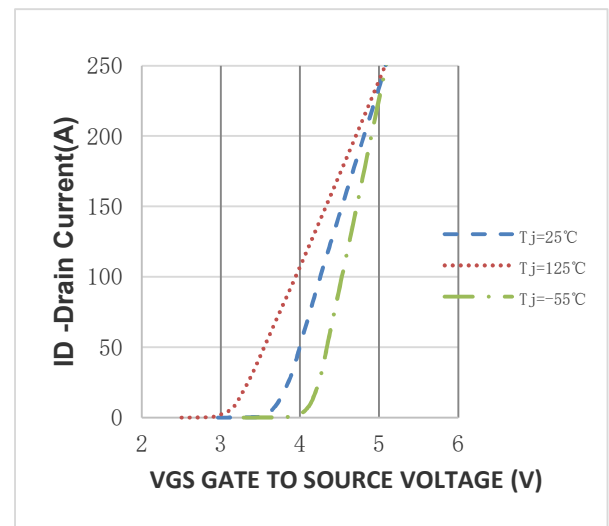


Fig.11 Safe Operating Area

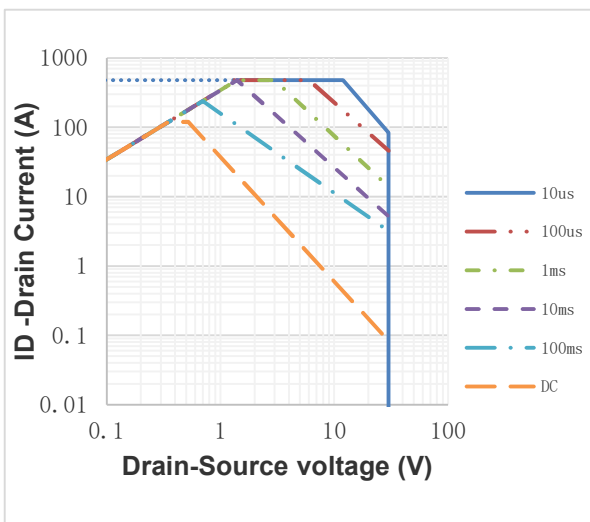
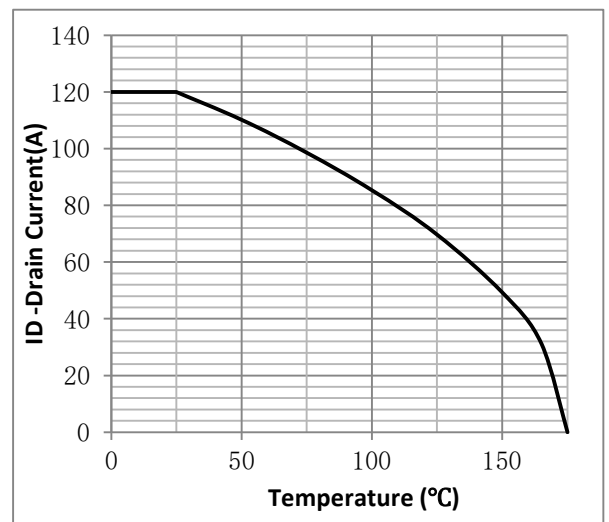
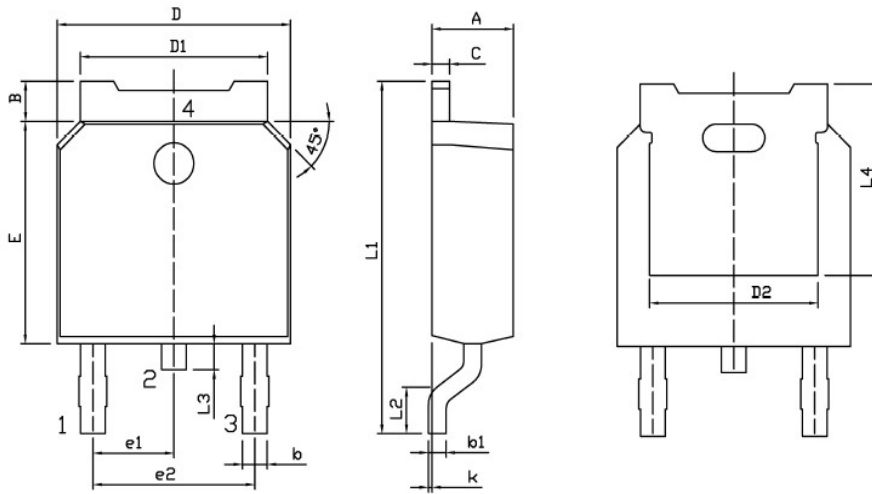


Fig.12 ID vs. Case Temperature<sup>③</sup>



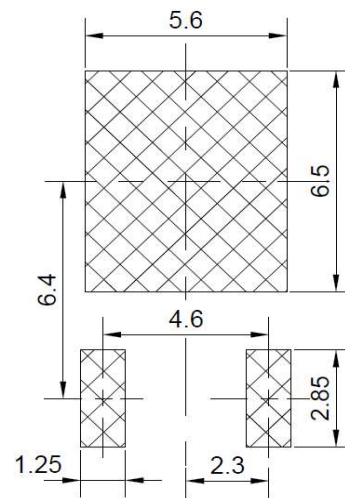
•TO-252 Package Outline

Option L:



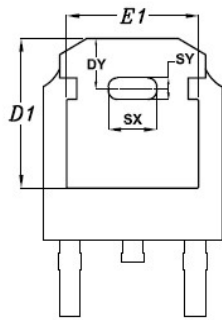
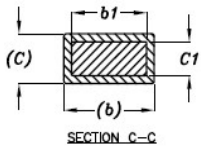
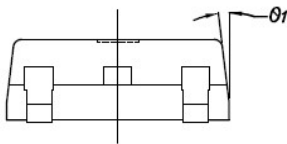
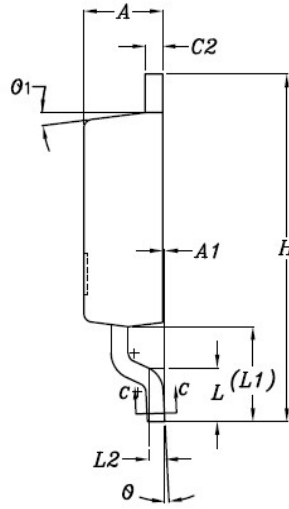
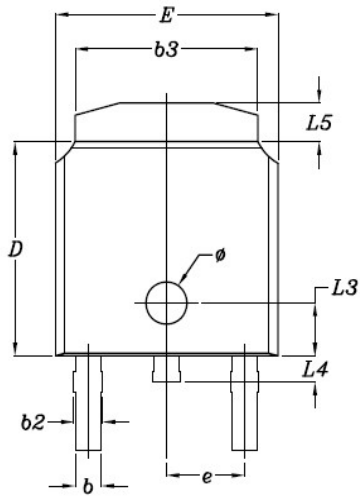
Dimensions In Millimeters					
Symbol	MIN	MAX	Symbol	MIN	MAX
A	2.20	2.40	E	5.95	6.25
B	0.95	1.25	e1	2.24	2.34
b	0.70	0.90	e2	4.43	4.73
b1	0.45	0.55	L1	9.85	10.35
C	0.45	0.55	L2	1.70	2.00
D	6.45	6.75	L3	0.60	0.90
D1	5.10	5.50	L4	5.05	
D2	4.85		k	0.00	0.10

Land Pattern  
(Only for Reference)



•TO-252 Package Outline

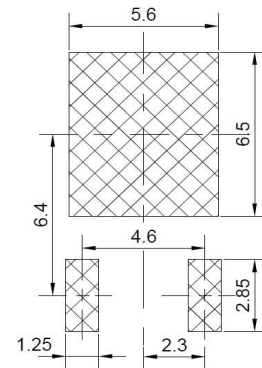
Option Q:



I T E M	DIMENSIONS			
	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	2.18	2.39	0.086	0.094
A1	—	0.13	—	0.005
b	0.70	0.89	0.028	0.035
b1	0.70	0.86	0.028	0.034
b2	0.76	1.14	0.030	0.045
b3	4.95	5.46	0.195	0.215
c	0.46	0.61	0.018	0.024
c1	0.41	0.56	0.016	0.022
c2	0.46	0.89	0.018	0.035
D	5.97	6.22	0.235	0.245
D1	5.21	5.54	0.205	0.218
E	6.35	6.73	0.250	0.265
E1	4.32	5.27	0.170	0.207
e	2.29 BSC		0.090 BSC	
H	9.40	10.41	0.370	0.410
L	1.40	1.78	0.055	0.070
L1	2.60	2.90	0.102	0.114
L2	0.51 BSC		0.020 BSC	
L3	1.65	1.95	0.065	0.077
L4	0.60	0.90	0.024	0.035
L5	0.89	1.27	0.035	0.050
phi	1"	5"	1"	5"
theta1	7° REF		7° REF	
phi	1.20 REF		0.047 REF	
SX	1.52 REF		0.060 REF	
SY	0.50 REF		0.020 REF	
DY	1.70 REF		0.067 REF	



Land Pattern  
(Only for Reference)



**Note:**

- ① Pulse :  $V_{GS}=+20V/-20V$ , Duty cycle=50%,  $T_j=175^{\circ}C$ ,  $t=1000$  hours; For DC , the following test conditions can be passed:  $V_{GS}=-20V/+10V$ ,  $T_j=175^{\circ}C$ ,  $t=1000$  hours;
- ② Device mounted on FR-4 substrate PC board, 2oz copper, with thermal bias to bottom layer 1inch square copper plate;
- ③ Practically the current will be limited by PCB, thermal design and operating temperature.  $V_{GS}=-10V$ .

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Revision History

Version	Date	Change
A	2021.2.3	NEW
B	2021.11.7	1.Modified Typical output Characteristics curve
C	2022.9.6	1.Add Reach,HF figure 2.Modified ID curve
D	2025.11.14	Update POD